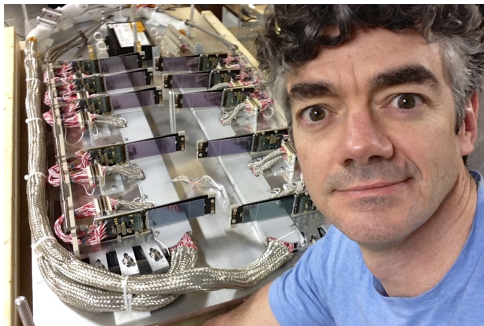


Test SVT operation at SLAC

Sho Uemura

SLAC



SVT test goals

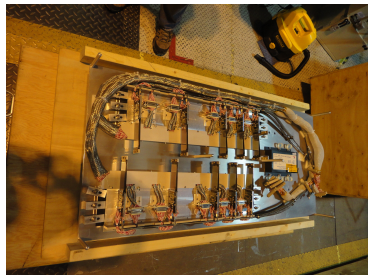
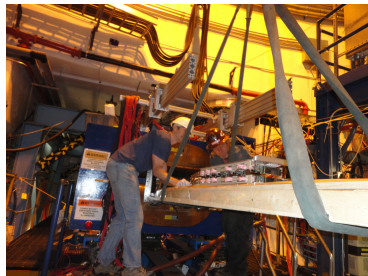
- Reproduce and debug issues seen in test run/pre-test run QA
 - ▶ Noisy readout chips, loss of sync
- Further needed studies
 - ▶ Reduce shaping time (50→35 ns)
 - ▶ Cold running
- Test bed for SVT
 - ▶ Controls: interlocks, motion controls, EPICS
 - ▶ JLab DAQ integration testing
 - ▶ New DAQ
 - ▶ New module designs
- Test rig for full SVT DAQ

Test setup requirements

- Duplicate running conditions for half of the test run SVT
 - ▶ Same DAQ, same cables, same power supplies
- Protect the detector
 - ▶ Layer 1–3 half-modules will be reused; don't damage or contaminate them
- Single-sensor setup for testing and QA
 - ▶ Update the QA setup with current firmware and cooling

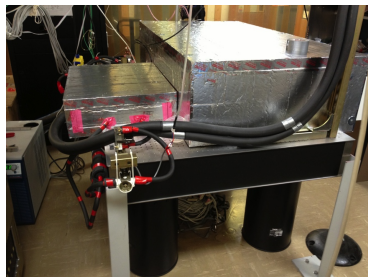
Getting the SVT back

- January: test run SVT extracted from vacuum chamber and shipped back to SLAC
 - ▶ Shipping box tested by unplanned cross-country truck ride
- CAEN power supplies also shipped to SLAC



Setup at SLAC

- Keep SVT in Lexan shipping enclosure
 - ▶ Add penetrations for cooling, data, dry air
 - ▶ Add outer thermal box to isolate from heat and light
- CAEN power supplies also shipped to SLAC
- Chiller (water-glycol to -10°C), valve manifold
- Air dryer to lower dew point in SVT enclosure; air kept clean by oil separators and point-of-use filters



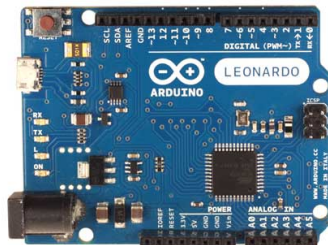
Power and DAQ

- CAEN crate controlled using serial console (no EPICS)
- DAQ crate set up as at JLab
- Installing JLab DAQ (CODA) at SLAC



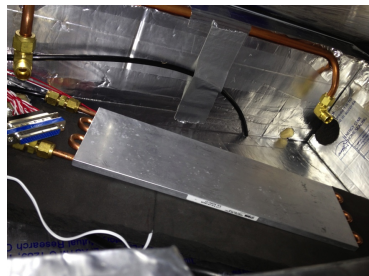
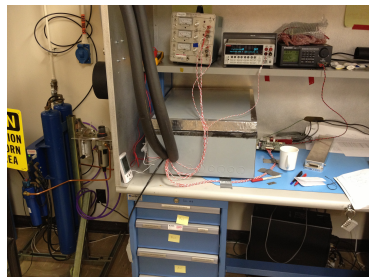
Interlocks

- Interlock:
 - ▶ SVT power is only enabled when SVT cooling flow is adequate and dew point is low
 - ▶ Chiller trips if cooling flow drops below nominal
- Interlock is built using Arduino microcontroller, which controls SVT power (CAEN crate-level interlock input) and chiller (RS-232 control) and sees the following inputs:
 - ▶ Humidity/air temperature sensor inside SVT enclosure
 - ▶ Flow switch in return line to chiller
- Highly configurable; could be used in other HPS applications



Test station

- DAQ development board in place of full DAQ
 - ▶ Shipping box tested by unplanned cross-country truck ride
- Cooling and dry air supplied from the same chiller and air dryer
- Same dew point monitoring scheme (sensor+Arduino)



First results

- Some early results from test station: cold running (18°C vs. 7°C)

